

250V, 220mΩ typ., 16A N-Channel MOSFET

General Description

The 16N25 uses advanced planar stripe DMOS technology and design to provide excellent RDS(ON). These devices are well suited for high efficiency switching DC/DC converters, switch mode power supplies, DC-AC converters for uninterrupted power supplies and motor controls.

Product Summary

BVDSS	RDS(on) max.	ID
250V	0.245Ω	16A

Applications

- Switch mode power supplies (SMPS)
- PWM Motor Controls
- DC-DC converters

TO-220/263/220F Pin Configuration

Features

- Low On-Resistance
- 100% avalanche tested
- Fast Switching
- RoHS Compliant

TO-220 TO-263 TO-220F (CMP16N25) (CMB16N25)

Absolute Maximum Ratings

Symbol	Parameter	220/263	220F	Units
V_{DS}	Drain-Source Voltage 250		50	V
V_{GS}	Gate-Source Voltage	±:	±30	
I _D @T _C =25°C	Continuous Drain Current	16	16*	Α
I _D @T _C =100°C	Continuous Drain Current	10	10*	Α
I _{DM}	Pulsed Drain Current ^(Note 1)	50	50*	Α
EAS	Single Pulse Avalanche Energy ^(Note 2)	360		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	5.5		V/ns
P _D @T _C =25°C	Total Power Dissipation	140	45	W
T _{STG}	Storage Temperature Range	-55 to 150		°C
T _J	Operating Junction Temperature Range -55 to 150		o 150	°C

^{*} Drain current limited by maximum junction temperature.

Thermal Data

Symbol	Parameter	220/263	220F	Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient	62.5	62.5	°C/W
R ₀ JC	Thermal Resistance Junction-case	0.9	2.78	°C/W

CMP16N25/CMB16N25/CMF16N25



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Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	250			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =250uA		0.31		V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V , I _D = 8A		0.22	0.245	Ω
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	2		4	V
	Dunin Course Looke as Course	V _{DS} =250V, V _{GS} =0V			10	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =200V , V _{GS} =0V , TC=125℃			100	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm30V$, V_{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =15V , I _D =8A (Note 4)		11		S
Qg	Total Gate Charge	I _D =16A		40	52	
Q _{gs}	Gate-Source Charge	V _{DS} =200V		5.5		nC
Q_gd	Gate-Drain Charge	V _{GS} = 10V (Note 4, 5)		23		
$T_{d(on)}$	Turn-On Delay Time	V _{DD} =125V		15		
T _r	Rise Time	I _D =16A		130		no
$T_{d(off)}$	Turn-Off Delay Time	R _G =25Ω		135		ns
T _f	Fall Time	(Note 4, 5)		105		
C _{iss}	Input Capacitance			1200		
C _{oss}	Output Capacitance	V _{DS} =25V , V _{GS} =0V , f=1MHz		170		pF
C _{rss}	Reverse Transfer Capacitance			55		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			16	Α
I _{SM}	Pulsed Source Current				50	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =15A , T _J =25℃			1.5	V
trr	Reverse Recovery Time	V _{GS} =0V, I _S =16A , T _j =25 °C d₁F/d₁=100A/µs		260		ns
Qrr	Reverse Recovery Charge			2.47		μC

Note

- 1. Repetitive Rating : Pulse width limited by maximum junction temperature
- 2. L = 1mH, I_{AS} = 27A, V_{DD} =50V, Starting T_J = 25°C
- 3. $I_{SD} \le 16 A, di/dt \le 300 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4.PulseTest Pulsewidth≤300µs,Dutycycle≤2%
- $5.\,Essentially\,independent of operating\,temperature$

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